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<u>کو</u> :	4	ETTER	020	Docket No. 02008/113001						
_	Application 10/600,919-Co		Filing D June 20,		Examiner V. P. Nguye	Examiner V. P. Nguyen				
Applicant(s): Yasuo Furukawa et al.										
Invention: AN LSI TESTING APPARATUS FOR TESTING AN ELECTRONIC DEVICE										
TO THE COMMISSIONER FOR PATENTS										
Transmitted herewith is an amendment in the above-identified application. 22511 The fee has been calculated and is transmitted as shown below. PATENT TRADEMARK OFFICE										
Γ	CLAIMS AS AMENDED									
ŀ	7	Claims	Highest) DED					
		Remaining After Amendment	Number Previously Paid	Number Extra Claims Present	Rate					
L	Total Claims	8	- 21 =		х					
	Independent Claims	1	- 3 =		x					
	Multiple Dependent Claims (check if applicable)									
Other fee (please specify):										
	TOTAL ADDITI	IONAL FEE FO	OR THIS AME	NDMENT:			0.00			
Ī	x Large Entity				Small Entity	,				
	X No additiona	al fee is require	d for this amer	ndment.						
[Please charge Deposit Account No in the amount of \$ A duplicate copy of this sheet is enclosed.									
	A check in the amount of \$ to cover the filing fee is enclosed.									
	Payment by credit card. Form PTO-2038 is attached.									
	The Director is hereby authorized to charge and credit Deposit Account No. 50-0591 as described below. A duplicate copy of this sheet is enclosed.									
	x Credit ar	ny overpaymen	nt.							
Charge any additional filing or application processing fees required under 37 CFR 1.16 and 1.17.										
_	Dated: August 12, 2005									
Frontomas K. Scherer T. Chyau Liang										
• /										
OSHA · LIANG LLP 1221 McKinney St., Suite 2800										
	Houston, Texas (713) 228-8600									
	(113) 220-0000									
I h	nereby certify that this	is correspondence is	s being deposited v	with the U.S. Post	tal Service as Express Mail	il, Airbill No.	EV736100897US,			
in	an envelope address nown below.	sed to: MS Amendr	nent, Commissione	fr for Patents, P.C	O. Box 1450, Alexandria, V	/A 22313-14	50, on the date			
Da	ated: August 12, 200	15	Dated: August 12, 2005 Signature:							



Docket No.: 02008/113001

(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Yasuo Furukawa et al.

Confirmation No.: 6910

Application No.: 10/600,919

Art Unit: 2829

Filed: June 20, 2003

Examiner: V. P. Nguyen

For: LSI TESTING APPARATUS

REPLY UNDER 37 C.F.R. § 1.116

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

22511
PATENT TRADEMARK OFFICE

Dear Sir:

In response to the final Office Action dated May 12, 2005, please reconsider the present application in view of the following.